Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10786554	TAKEHARA, SHINTARO
Examiner	Art Unit

2627

SEARCHED			
Class	Subclass	Date	Examiner

HENOK G HEYI

SEARCH NOTES		
Search Notes	Date	Examiner
Searched EAST and refered to previous examiner's notes.	03/19/2008	Henok Heyi
Search updated and consulted Primary Tan Dinh.	10/21/2008	Henok Heyi

INTERFERENCE SEARCH				
Class	Subclass	Date	Examiner	
369	44.35 (text search only - see search history)	10/21/2008	Henok Heyi	
369	44.36 (text search only - see search history)	10/21/2008	Henok Heyi	
369	275.4 (text search only - see search history)	10/21/2008	Henok Heyi	

/HENOK G HEYI/ Examiner.Art Unit 2627	

U.S. Patent and Trademark Office Part of Paper No.: 20081021